

## Ieee Standard C Atlas Test Language

Wescon/84 Conference Record  
Index to IEEE Publications  
IEEE Standard C/ATLAS  
Model-Based Testing for Embedded Systems  
Books in Print  
The IEEE Standard Dictionary of Electrical and Electronics Terms  
CD-ROM Book Index  
Bibliographic Guide to Technology  
IEEE Proceedings of the Southeastcon '91  
IEEE Standard C/ATLAS  
Autotestcon '82, October 12-14  
Journal of Semicustom ICs  
Autotestcon '80  
Quick Reference to IEEE Standards  
Quick Reference to IEEE Standards  
IEEE Standard ATLAS Test Language  
Electronic Products  
IEEE Standard C/ATLAS Syntax  
Digital Avionics Systems  
Autotestcon '87  
IEEE Standard C/ATLAS  
Books in print supplement 1988-89  
International Journal of Electrical Engineering Education  
Conference Record  
QRIS, Quick Reference to IEEE Standards  
Subject Catalog  
Proceedings  
Computer Books and Serials in Print  
Standard Test Language for All Systems--common/abbreviated Test Language for All Systems (C/ATLAS)  
Proceedings of Seventh Annual National Conference on Ada Technology  
Index of Specifications and Standards  
National Union Catalog  
IEEE Standard ATLAS Test Language  
Test Technology and Commercialization  
IEEE Autotestcon Proceedings  
IEEE Standard C/ATLAS  
IEEE Standard C/ATLAS Test Language  
IEEE Instrumentation and Measurement Technology Conference Proceedings  
Computer Age, Software Digest  
IEEE ABBET Standard for Test Equipment Description Language (TEDL)

### Wescon/84 Conference Record

### Index to IEEE Publications

### IEEE Standard C/ATLAS

Früher u.d.T.: Institute of Electrical and Electronics Engineers: The new IEEE standard dictionary of electrical and electronics terms.

### Model-Based Testing for Embedded Systems

### Books in Print

### The IEEE Standard Dictionary of Electrical and Electronics Terms

### CD-ROM Book Index

### Bibliographic Guide to Technology

## **IEEE Proceedings of the Southeastcon '91**

What the experts have to say about Model-Based Testing for Embedded Systems: "This book is exactly what is needed at the exact right time in this fast-growing area. From its beginnings over 10 years ago of deriving tests from UML statecharts, model-based testing has matured into a topic with both breadth and depth. Testing embedded systems is a natural application of MBT, and this book hits the nail exactly on the head. Numerous topics are presented clearly, thoroughly, and concisely in this cutting-edge book. The authors are world-class leading experts in this area and teach us well-used and validated techniques, along with new ideas for solving hard problems. "It is rare that a book can take recent research advances and present them in a form ready for practical use, but this book accomplishes that and more. I am anxious to recommend this in my consulting and to teach a new class to my students." —Dr. Jeff Offutt, professor of software engineering, George Mason University, Fairfax, Virginia, USA "This handbook is the best resource I am aware of on the automated testing of embedded systems. It is thorough, comprehensive, and authoritative. It covers all important technical and scientific aspects but also provides highly interesting insights into the state of practice of model-based testing for embedded systems." —Dr. Lionel C. Briand, IEEE Fellow, Simula Research Laboratory, Lysaker, Norway, and professor at the University of Oslo, Norway "As model-based testing is entering the mainstream, such a comprehensive and intelligible book is a must-read for anyone looking for more information about improved testing methods for embedded systems. Illustrated with numerous aspects of these techniques from many contributors, it gives a clear picture of what the state of the art is today." —Dr. Bruno Legeard, CTO of Smartesting, professor of Software Engineering at the University of Franche-Comté, Besançon, France, and co-author of Practical Model-Based Testing

## **IEEE Standard C/ATLAS**

A complete index of all terms in IEEE standards and ANSI standards published by IEEE, together with tables of contents of all the documents indexed.

## **Autotestcon '82, October 12-14**

## **Journal of Semicustom ICs**

## **Autotestcon '80**

This standard defines ATLAS, the Abbreviated Test Language for All Systems, which offers a standardized test language for expressing test specifications and test procedures.

## **Quick Reference to IEEE Standards**

## **Quick Reference to IEEE Standards**

## **IEEE Standard ATLAS Test Language**

### **Electronic Products**

## **IEEE Standard C/ATLAS Syntax**

### **Digital Avionics Systems**

### **Autotestcon '87**

## **IEEE Standard C/ATLAS**

### **Books in print supplement 1988-89**

## **International Journal of Electrical Engineering Education**

### **Conference Record**

## **QRIS, Quick Reference to IEEE Standards**

A complete index of all terms in IEEE Standards and ANSI Standards published by IEEE, together with tables of contents of all the documents indexed.

## **Subject Catalog**

### **Proceedings**

## **Computer Books and Serials in Print**

## **Standard Test Language for All Systems--common/abbreviated Test Language for All Systems (C/ATLAS)**

Includes entries for maps and atlases.

## **Proceedings of Seventh Annual National Conference on Ada Technology**

## **Index of Specifications and Standards**

## **National Union Catalog**

## **IEEE Standard ATLAS Test Language**

## **Test Technology and Commercialization**

## **IEEE Autotestcon Proceedings**

## **IEEE Standard C/ATLAS**

## **IEEE Standard C/ATLAS Test Language**

Issues for 1973- cover the entire IEEE technical literature.

## **IEEE Instrumentation and Measurement Technology Conference Proceedings**

A high order language for testing is defined. This language is designed to describe tests in terms that are independent of any specific test system, and has been constrained to ensure that it can be implemented on automatic test equipment.

## **Computer Age, Software Digest**

## **IEEE ABBET Standard for Test Equipment Description Language (TEDL)**

[ROMANCE](#) [ACTION & ADVENTURE](#) [MYSTERY & THRILLER](#) [BIOGRAPHIES & HISTORY](#) [CHILDREN'S](#) [YOUNG ADULT](#) [FANTASY](#) [HISTORICAL FICTION](#) [HORROR](#) [LITERARY FICTION](#) [NON-FICTION](#) [SCIENCE FICTION](#)